

UNISONIC TECHNOLOGIES CO., LTD

9N80 Preliminary Power MOSFET

9 Amps, 800 Volts N-CHANNEL POWER MOSFET

■ DESCRIPTION

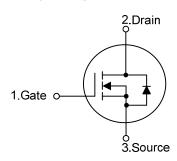
The UTC **9N80** is an N-channel mode Power FET using UTC's advanced technology to provide costumers with planar stripe and DMOS technology. This technology is specialized in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC **9N80** is universally applied in high efficiency switch mode power supply.



- * Improved Gate Charge
- * Lower Input Capacitance
- * Lower Leakage Current: 25 μA (Max.) @ V_{DS} = 800V
- * Halogen Free

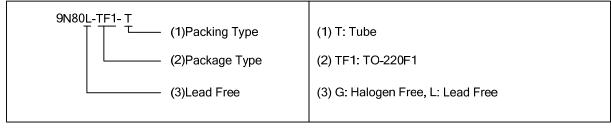


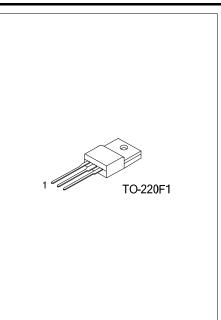


■ ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
9N80L-TF1-T	9N80G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source





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■ **ABSOLUTE MAXIMUM RATINGS**(T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	800	V
Gate-Source Voltage		V_{GSS}	±30	٧
Avalanche Current (Note 1)		I _{AR} 9		Α
Drain Current (Continuous)	Continuous	nuous I _D		Α
	Pulsed (Note 1)	I _{DM}	36	Α
Avalanche Energy	Single Pulsed (Note 2)	E _{AS}	900	mJ
	Repetitive (Note 1)	E _{AR}	24	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	2.0	V/ns
Power Dissipation		P_{D}	49	W
Junction Temperature		T _J +150		Ô
Storage Temperature		T _{STG}	-55~+150	°C
Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.				

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θıc	2.55	°C/W	

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

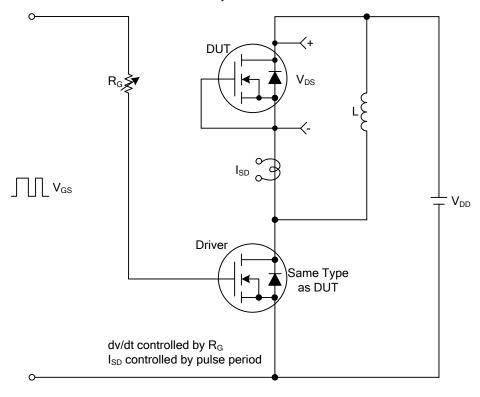
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	800			V
Breakdown Voltage Temperature		△BV _{DSS} /△T _J	I_ =250u A		0.96		V/°C
Coefficient			10-230μΑ,		0.90		V/ C
Drain-Source Leakage Current		I _{DSS}	V _{DS} =800V			25	μΑ
Gate- Source Leakage Current	Forward	I _{GSS}	V _{GS} =+30V			+100	nA
	Reverse	IGSS	V _{GS} =-30V			-100	nA
ON CHARACTERISTICS		T	,	1	ı	ı	1
Gate Threshold Voltage		$V_{GS(TH)}$	V _{DS} =5V, I _D =250μA			3.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =4.5A (Note 4)			1.3	Ω
Forward Transconductance		g FS	V _{DS} =50V, I _D =4.5A (Note 4)		5.54		S
DYNAMIC PARAMETERS						•	
Input Capacitance		C _{ISS}			2020	2600	pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz,		195	230	pF
Reverse Transfer Capacitance		C _{RSS}			82	95	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =640V, I _D =9A,		93	120	nC
Gate to Source Charge		Q_{GS}	(Note 4, 5)		14.3		nC
Gate to Drain Charge		Q_{GD}	(14016 4, 3)		42.1		nC
Turn-ON Delay Time		t _{D(ON)}			25	60	ns
Rise Time		t _R	V_{DD} =400V, I_D =9 A, R_G =16 Ω ,		37	85	ns
Turn-OFF Delay Time		t _{D(OFF)}	(Note 4. 5)		113	235	ns
Fall-Time	Fall-Time				42	95	ns
SOURCE- DRAIN DIODE RATII	NGS AND	CHARACTERIS	STICS				
Maximum Body-Diode Continuous Current		Is	Integral reverse pn-diode in the			9	Α
Maximum Pulsed Drain-Source Diode		I _{SM}	mosfet			36	Α
Forward Current (Note 1)						30	А
Drain-Source Diode Forward Voltage		V_{SD}	I _S =9A, V _{GS} =0V, T _J =25°C			1.4	V
(Note 4)		V SD	15-3A, VGS-0V, 1J-23 O			1.7	v
Reverse Recovery Time		t _{RR}	T _J =25°C, I _F =9A, dI _F /dt=100A/μs, (Note 4)		560		ns
Reverse Recovery Charge		Q_{RR}			8.4		μC

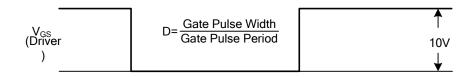
Note: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

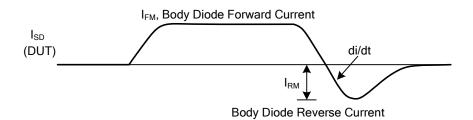
- 2. L = 21mH, I_{AS} = 9A, V_{DD} = 50V, R_G = 27 Ω , Starting T_J = 25°C
- 3. $I_{SD} \le 9A$, di/dt $\le 180A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width ≤ 250µs, Duty cycle ≤ 2%
- 5. Essentially independent of operating temperature

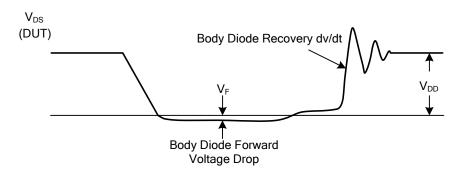
■ TEST CIRCUITS AND WAVEFORMS

Peak Diode Recovery dv/dt Test Circuit & Waveforms









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